## JAN 12 2007 w

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

(Our Case No. 03-11)

In the	application of:	)
	Wan Yen Teoh et al.	· )
Serial	No.: 10/791,417	) Examiner: Arpan P. Savla
Filed:	March 2, 2004	) Group Art Unit: 2185
For:	Cycling through Addresses of a Memory Device with Minimized Charge Gain Failure	) )

Commissioner for Patents

Mail Stop RCE

P.O. Box 1450

Alexandria, VA 22313-1450

## AMENDMENT AND RESPONSE AS SUBMISSION FOR RCE

Applicant submits the following with the Request for Continued Examination (RCE), and a fee of \$790 is enclosed for the RCE.

In response to the Office Action of May 2, 2006, please amend the above-identified application as follows:

Amendments to the Specification: Begin on page 2 of this paper.

Amendments to the Claims: Are reflected in the listing of claims which begins on page 3 of this paper.

Amendments to the Drawings: None.

Remarks/Arguments: Begin on page 7 of this paper.